

Special Issue

Selected Papers from the 1st International Conference of the Chinese Society of Micro/Nano Technology

Message from the Guest Editor

Summary The 1st International Conference of the Chinese Society of Micro/Nano Technology The 1st International Conference of the Chinese Society of Micro/Nano Technology was held in Beijing, China on November 19-21, 2008. The conference brought together top researchers from around the world to exchange research results and address open issues in all aspects of micro/nano technology. This special issue collects best papers from more than 300 contributions.

Guest Editor

Dr. Xiaohao Wang

Associate Professor, Department of Precision Instruments and Mechanology, Tsinghua University, Beijing 100084, China

Deadline for manuscript submissions

closed (15 March 2009)



Sensors

an Open Access Journal
by MDPI

Impact Factor 3.5
CiteScore 8.2
Indexed in PubMed



mdpi.com/si/294

Sensors
Editorial Office
MDPI, Grosspeteranlage 5
4052 Basel, Switzerland
Tel: +41 61 683 77 34
sensors@mdpi.com

[mdpi.com/journal/
sensors](http://mdpi.com/journal/sensors)





Sensors

an Open Access Journal
by MDPI

Impact Factor 3.5
CiteScore 8.2
Indexed in PubMed



[mdpi.com/journal/
sensors](https://mdpi.com/journal/sensors)



About the Journal

Message from the Editor-in-Chief

Sensors is a leading journal devoted to fast publication of the latest achievements of technological developments and scientific research in the huge area of physical, chemical and biochemical sensors, including remote sensing and sensor networks. Both experimental and theoretical papers are published, including all aspects of sensor design, technology, proof of concept and application. Sensors organizes Special Issues devoted to specific sensing areas and applications each year.

Editor-in-Chief

Prof. Dr. Vittorio M. N. Passaro

Dipartimento di Ingegneria Elettrica e dell'Informazione (Department of Electrical and Information Engineering), Politecnico di Bari, Via Edoardo Orabona n. 4, 70125 Bari, Italy

Author Benefits

Open Access:

free for readers, with article processing charges (APC) paid by authors or their institutions.

High Visibility:

indexed within Scopus, SCIE (Web of Science), PubMed, MEDLINE, PMC, Ei Compendex, Inspec, Astrophysics Data System, and other databases.

Journal Rank:

JCR - Q2 (Instruments and Instrumentation) / CiteScore - Q1 (Instrumentation)